

LIM – A General-Purpose Simulator for High-Speed Circuit Design

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Outline

- **LIM vs MNA**
- **LIM Components**
- **LIM & IBIS**
- **LIM & Macromodeling**
- **LIM Format & Support**



Commercial Simulators - Comparison

	Vendor_0	Vendor_1	Vendor_2	Vendor_3	Vendor_4	Vendor_5	LIM
Frequency Dependence	NO	YES	YES	NO	NO	YES	YES
Uses MNA	YES	YES	YES	YES	YES	YES	NO
BSIM-CMG	NO	YES	YES	YES	YES	NO	NOT YET

MNA: Modified Nodal Analysis

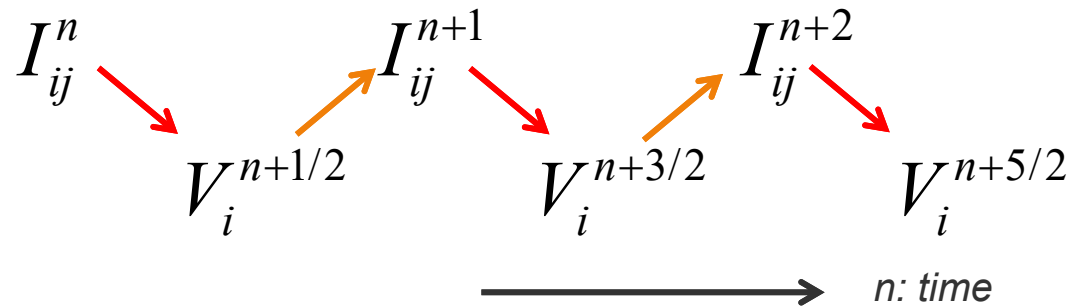


Why LIM?

- MNA has super-linear numerical complexity
- LIM has linear numerical complexity
- LIM has no matrix ill-conditioning problems
- Accuracy and stability in LIM are easily controlled
- LIM is much faster than MNA for large circuits



LIM: Leapfrog Method



$$V_i^{n+1/2} = \frac{\frac{C_i V_i^{n-1/2}}{\Delta t} + H_i^n - \sum_{k=1}^{N_a} I_{ik}^n}{\frac{C_i}{\Delta t} + G_i}$$

$$I_{ij}^{n+1} = I_{ij}^n + \frac{\Delta t}{L_{ij}} (V_i^{n+1/2} - V_j^{n+1/2} - R_{ij} I_{ij}^n)$$

Leapfrog method achieves second-order accuracy, i.e., error is proportional to Δt^2

VinC – Voltage in Current*

$$V_i^{n+1} = \frac{\frac{C_i V_i^{n-1}}{\Delta t} + H_i^{n+1/2} - \sum_{k=1}^{N_a} I_{ik}^{n+1/2}}{\frac{C_i}{\Delta t} + G_i} = \Gamma_i V_i^n + Z_{ni} H_i^{n+1/2} - Z_{ni} \sum_{k=1}^{N_a} I_{ik}^{n+1/2}$$

$I_{ij}^{n+1/2} = I_{ij}^{n-1/2} + \frac{\Delta t}{L_{ij}} \left(V_i^{n+1} - V_j^{n+1} - R_{ij} I_{ij}^{n-1/2} \right)$

Algebraic sum of all currents incident at node i except that of branch ij

$$I_{ij}^{n+1/2} = \frac{I_{ij}^{n-1/2} + \frac{\Delta t}{L_{ij}} \left(\Gamma_i V_i^n + Z_{ni} H_i^{n+1/2} - Z_{ni} \sum_{k=1, k \neq j}^{N_a} I_{ik}^{n+1/2} - \Gamma_j V_j^n - Z_{nj} H_j^{n+1/2} + Z_{nj} \sum_{k=1, k \neq j}^{N_a} I_{jk}^{n+1/2} - R_{ij} I_{ij}^{n-1/2} \right)}{\left[1 + Z_{ni} \frac{\Delta t}{L_{ij}} + Z_{nj} \frac{\Delta t}{L_{ij}} \right]}$$

VinC formulation achieves higher accuracy and stability

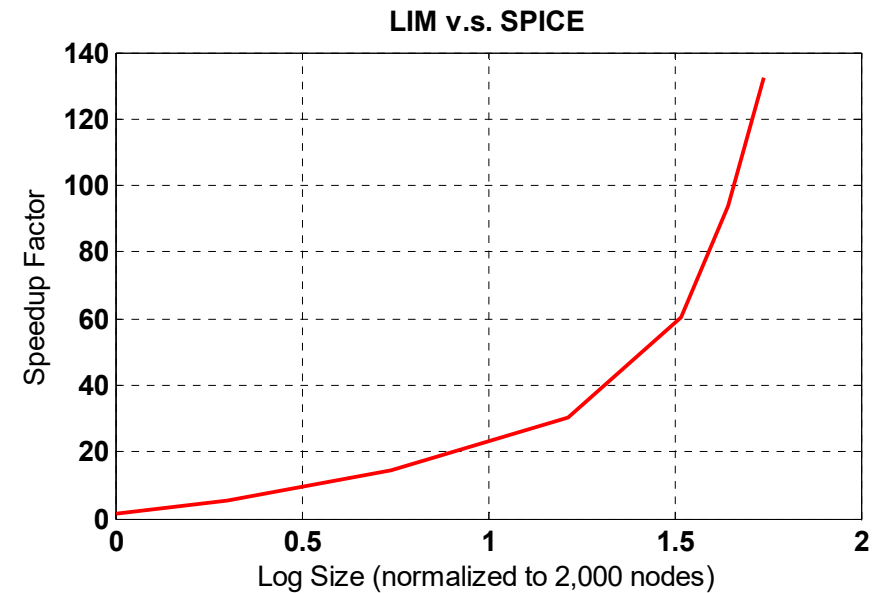
* K.H. Tan, P. Goh and M.F. Ain, "Voltage-in-current formulation for the latency insertion method for improved stability", *Electronics Letters*, vol. 52, no. 23, Nov. 2016, pp. 1904-1906.



LIM vs SPICE

Simulation Times

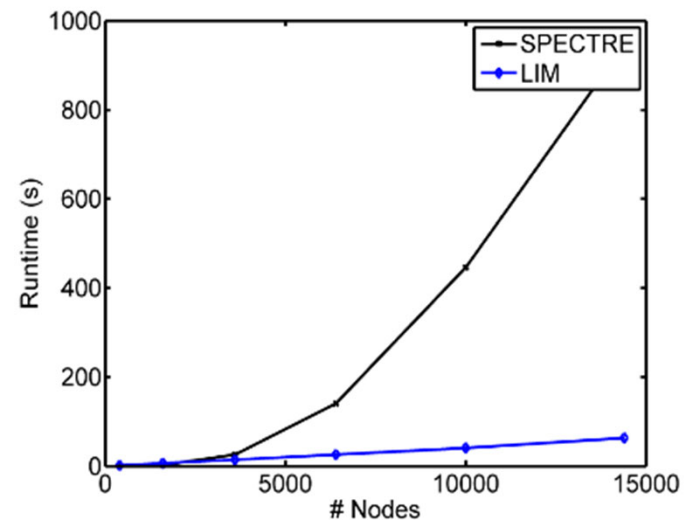
No of Nodes	20,000	30,000	40,000	50,000
SPICE (sec)	1224	2935	4741	7358
LIM (sec)	9	13	17	21
Speedup	136	225	278	350



Example – RLGC Grid

- Comparison of runtime for LIM and Vendor_3.

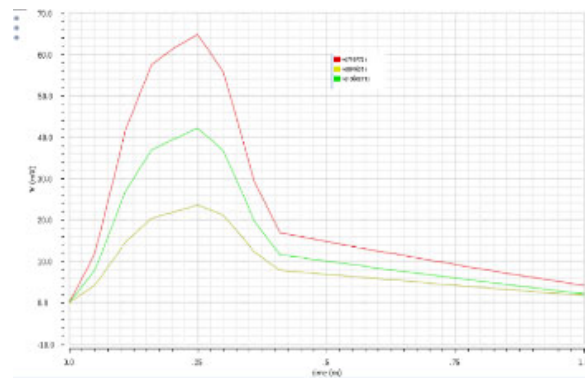
Circuit Size	# nodes	VENDOR_3 (s)	LIM (s)
20 × 20	400	0.15	1.53
40 × 40	1600	2.14	6.25
60 × 60	3600	25.73	14.23
80 × 80	6400	140.59	25.71
100 × 100	10000	445.77	40.64
120 × 120	14400	945.00	62.89



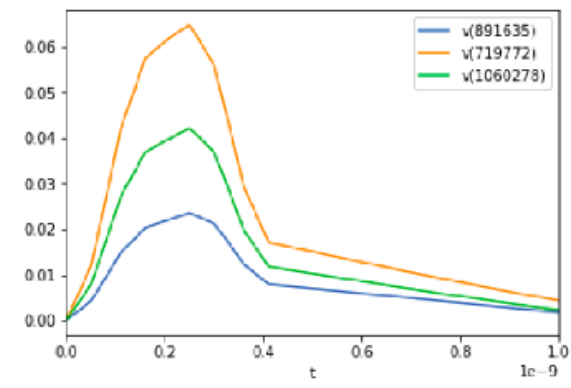
- LIM exhibits linear numerical complexity!
 - Outperforms conventional SPICE-like simulators.

LIM – Simulation of Large Circuits

VENDOR_3



VENDOR_0



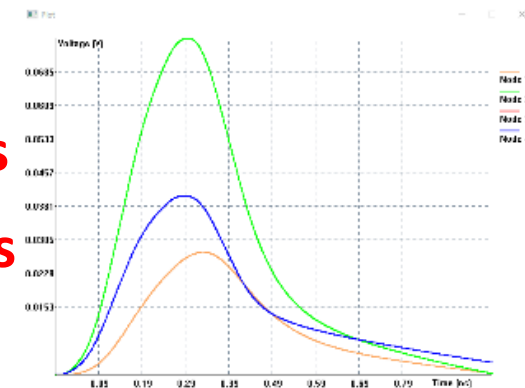
- 2,029,744 series resistors
- 380,742 shunt resistors
- 380,742 series capacitors
- 380,742 shunt capacitors
- 381 series inductors
- 835,858 series voltage sources
- 381 shunt voltage sources
- 761,484 shunt current sources

VENDOR_3: 1 day 20 hours 44 minutes

VENDOR_0: 3 days 2 hours 57 minutes

LIM: 2 hours 37 minutes 39 seconds

LIM



Large Circuit Results*

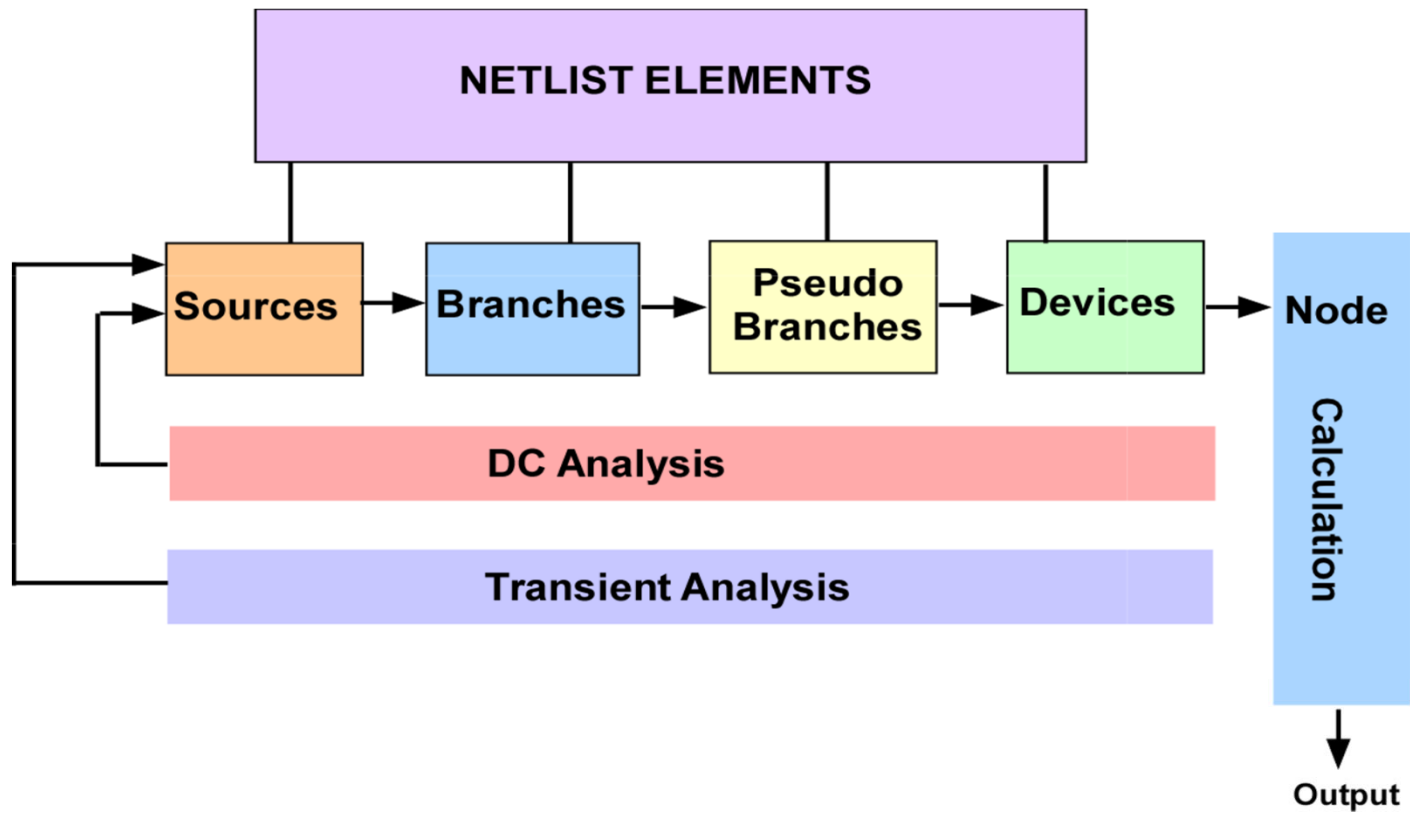
TABLE 3. Time spent per iteration for Vendor_5 and VinC LIM in full TFT FPD circuits.

Circuit size (in pixels)	No. of nodes	No. of TFTs	Time per iteration (s)		Speedup ratio
			Vendor_5	VinC LIM	
20×12	5,867	5,040	0.032	0.015	2.13×
25×20	12,159	10,500	0.080	0.030	2.67×
80×36	69,479	60,480	0.803	0.182	4.41×
100×100	240,851	210,000	6.362	0.677	9.40×
320×180	1,383,915	1,209,600	256.51	4.118	62.29×
640×360	5,532,627	4,838,400	4393.41	18.83	233.32×
960×540	12,446,147	10,886,400	dnc.	43.78	-
1920×1080	49,775,555	43,545,600	dnc.	193.30	-

*Wei Chun Chin, Andrei Pashkovich, José E. Schutt-Ainé, Nur Syazreen Ahmad, Patrick Goh., "Thin-Film Transistor Simulations With the Voltage-In-Current Latency Insertion Method", *IEEE Access*, Volume 9, 2021.



Simulator Flow



LIM Simulator Development

TYPES OF ANALYSIS

DC Analysis

AC Small-Signal Analysis

Transient Analysis

Pole-Zero Analysis

Small-Signal Distortion Analysis

Sensitivity Analysis

Noise Analysis

Done

In Development



LIM Simulator Development

ELEMENTARY DEVICES

Resistors
Capacitors
Inductors
Mutual Inductors

INDEPENDENT SOURCES

Pulse
Sinusoidal
Exponential
Piece-Wise Linear
Pseudo-random Bit Sequence

DEPENDENT SOURCES

Voltage-Controlled Current Sources
Voltage-Controlled Voltage Sources
Current-Controlled Current Sources
Current-Controlled Voltage Sources

TRANSMISSION LINES

Lossless Single Transmission Lines
Lossy Single Transmission Lines
Lossless Multiconductor Transmission Lines
Lossy Multiconductor Transmission Lines

MACROMODELS

Model-Order Reduction
Convolution Model

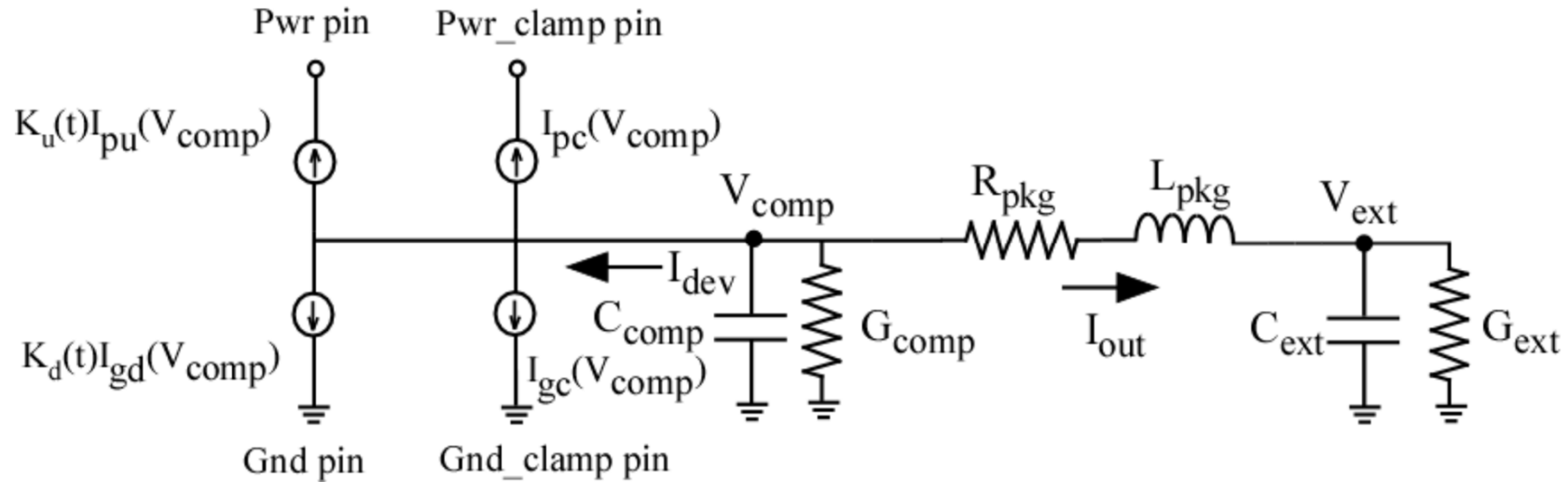
DEVICES

Junction Diodes
Bipolar Junction Transistors (BJTs)
Junction Field-Effect Transistors (JFETs)
MOSFETs
MESFETs

Done
In Development



IBIS-LIM Formulation



$$C_{ext} \frac{(V_{ext}^{n+1/2} - V_{ext}^{n-1/2})}{\Delta t} + \frac{G_{ext}}{2} (V_{ext}^{n+1/2} + V_{ext}^{n-1/2}) = I_{out}^n$$

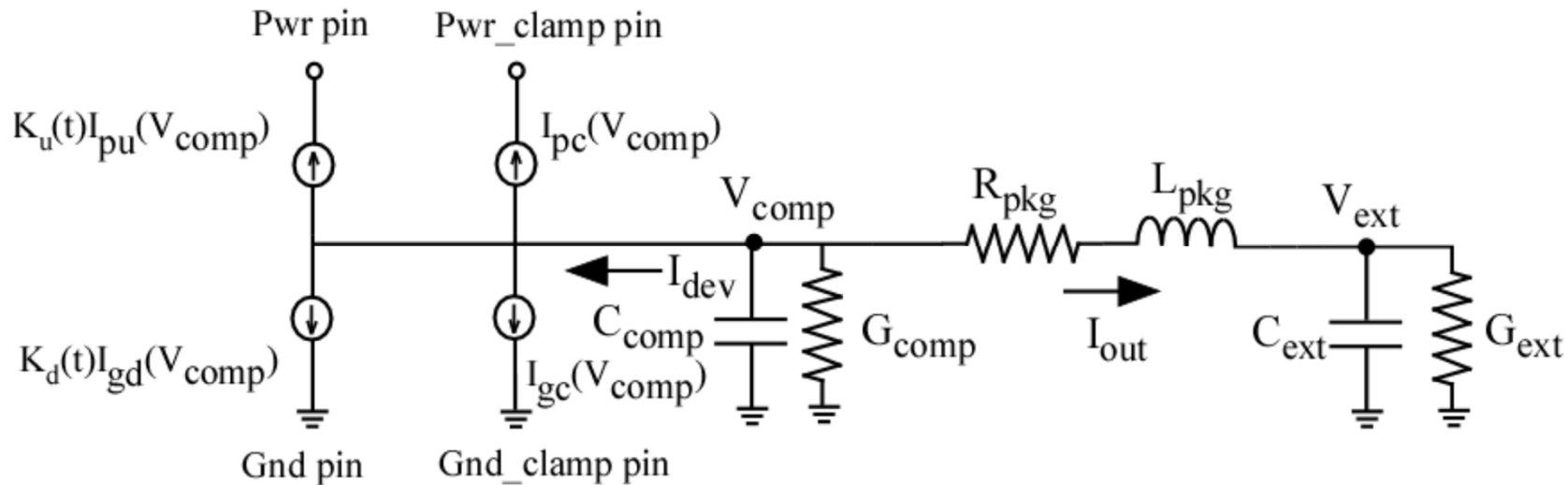
$$V_{ext}^{n+1/2} = \frac{I_{out}^n + \left(\frac{C_{ext}}{\Delta t} - \frac{G_{ext}}{2} \right) V_{ext}^{n-1/2}}{\left(\frac{C_{ext}}{\Delta t} + \frac{G_{ext}}{2} \right)}$$

$$V_{comp}^{n+1/2} - V_{ext}^{n+1/2} = L_{pkg} \frac{(I_{out}^{n+1} - I_{out}^n)}{\Delta t} + \frac{R_{pkg}}{2} (I_{out}^{n+1} + I_{out}^n)$$

$$I_{out}^{n+1} = \frac{(V_{comp}^{n+1/2} - V_{ext}^{n+1/2}) + I_{out}^n \left(\frac{L_{pkg}}{\Delta t} - \frac{R_{pkg}}{2} \right)}{\left(\frac{L_{pkg}}{\Delta t} + \frac{R_{pkg}}{2} \right)}$$



IBIS-LIM Solution



$$C_{comp} \frac{(V_{comp}^{n+1/2} - V_{comp}^{n-1/2})}{\Delta t} + \frac{G_{comp}}{2} (V_{comp}^{n+1/2} + V_{comp}^{n-1/2}) = -I_{out}^n - I_{dev}^n$$

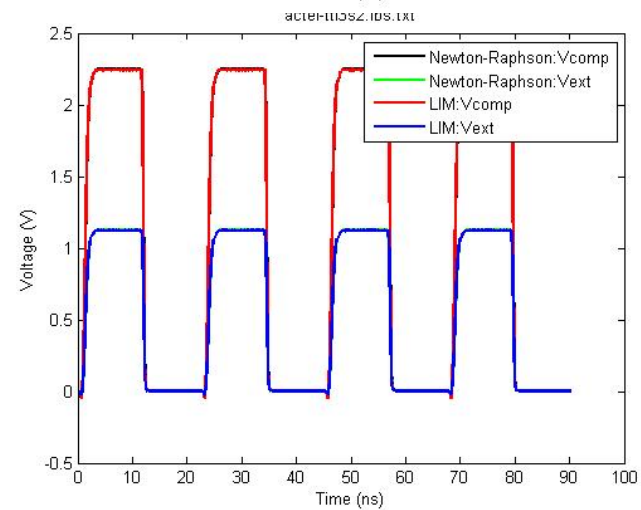
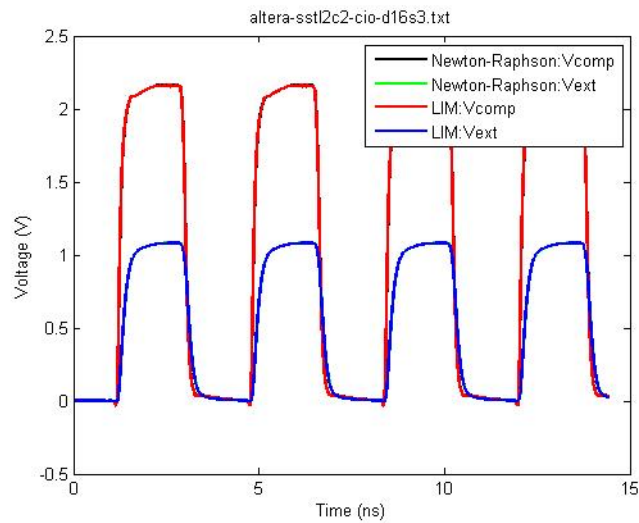
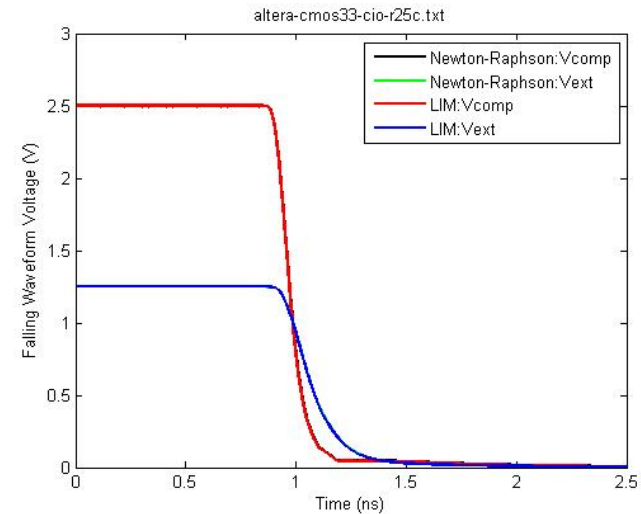
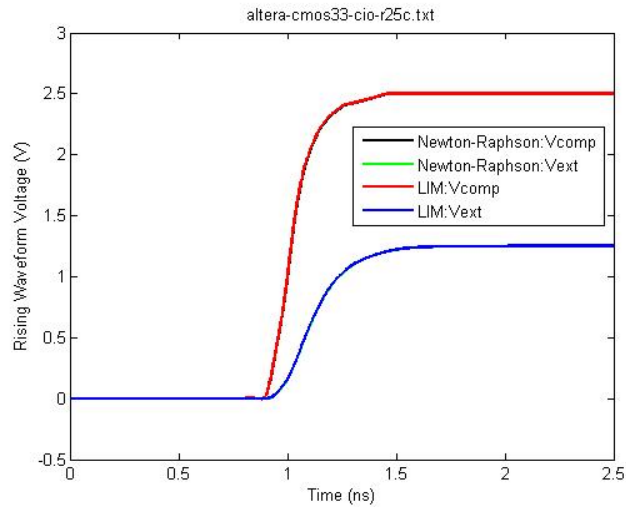
$$V_{comp}^{n+1/2} = \frac{-I_{out}^n - I_{dev}^n + \left(\frac{C_{comp}}{\Delta t} - \frac{G_{comp}}{2} \right) V_{comp}^{n-1/2}}{\left(\frac{C_{comp}}{\Delta t} + \frac{G_{comp}}{2} \right)}$$

Explicit equations

$$I_{dev}^n = K_u I_{pu}(V_{comp}) + K_d I_{pd}(V_{comp}) + I_{pc}(V_{comp}) + I_{gc}(V_{comp})$$

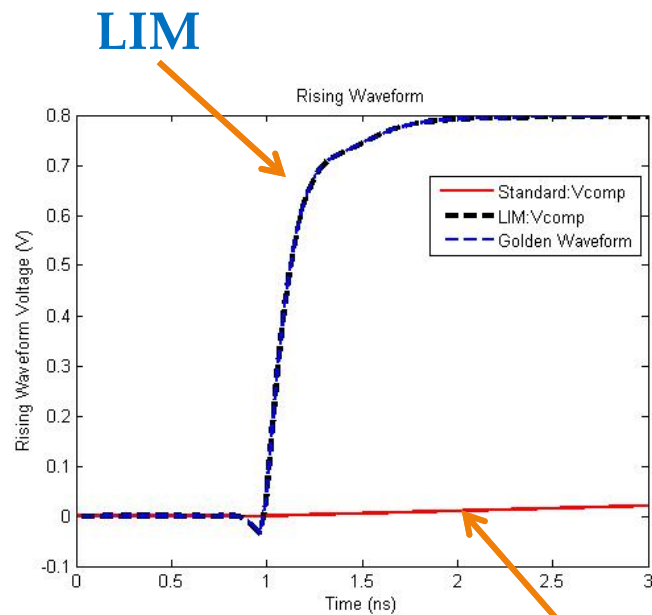
Transient Simulation Examples

NR and LIM give same results...

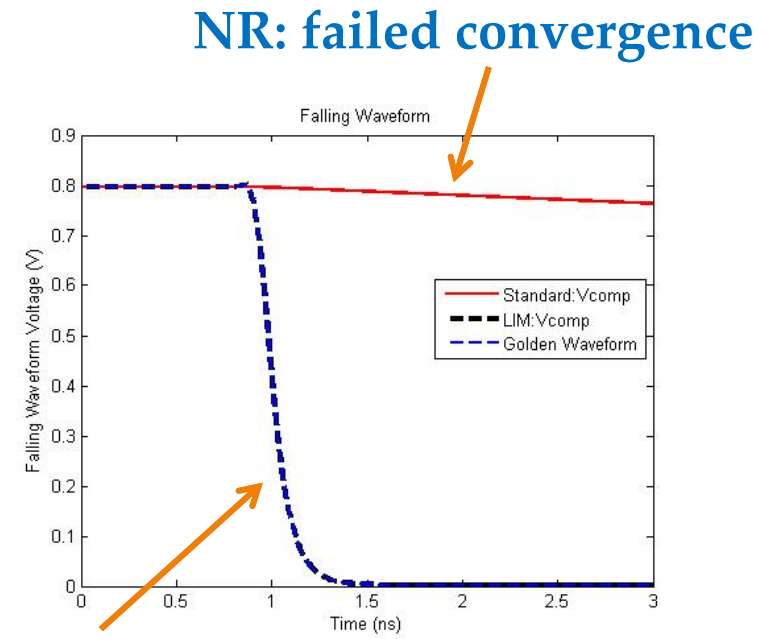


Transient Simulation Examples

... in some cases Newton-Raphson fails to converge...



NR: failed convergence



LIM

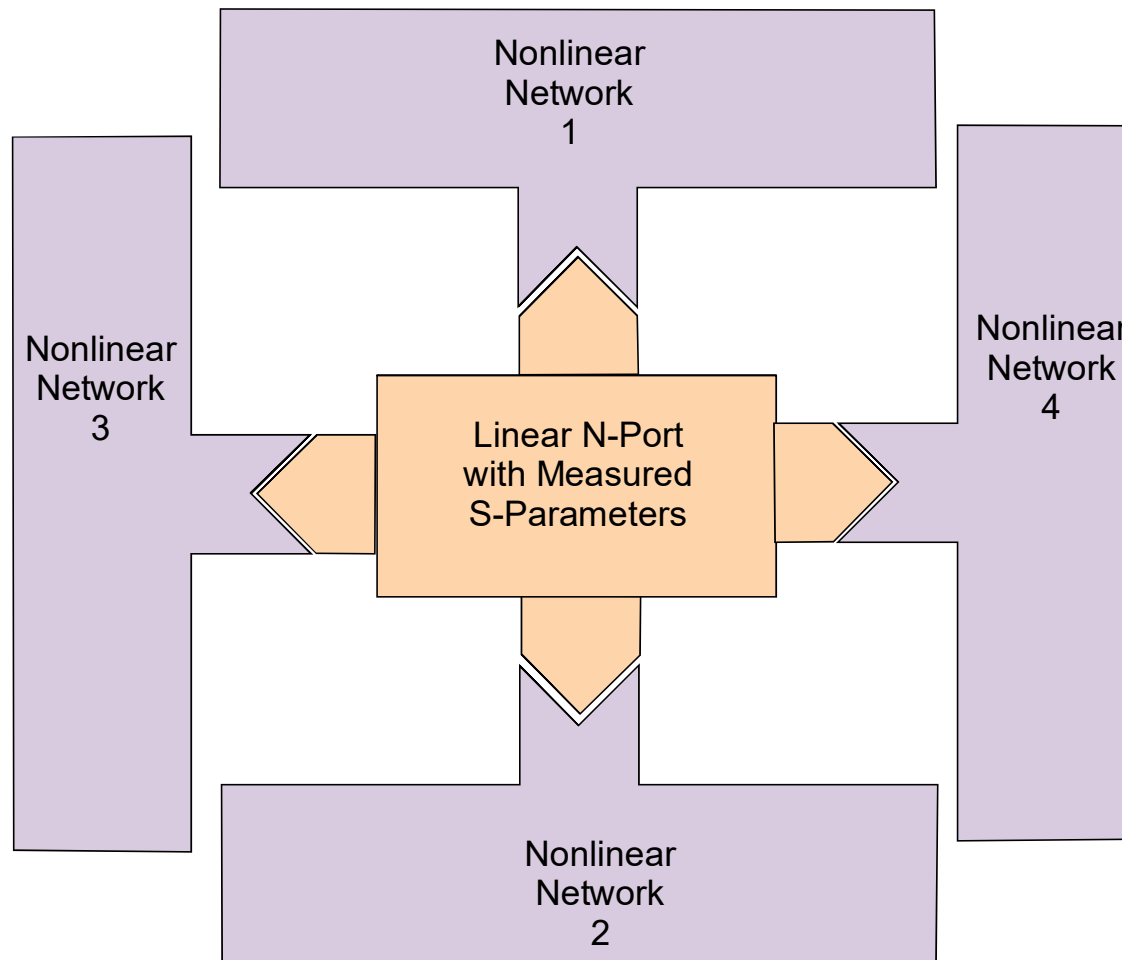


LIM and IBIS

- **Demonstrated**
- **BIRDs 98 and 95 implemented**
- **Need to integrate latest improvements**
- **Need to integrate AMI capability**

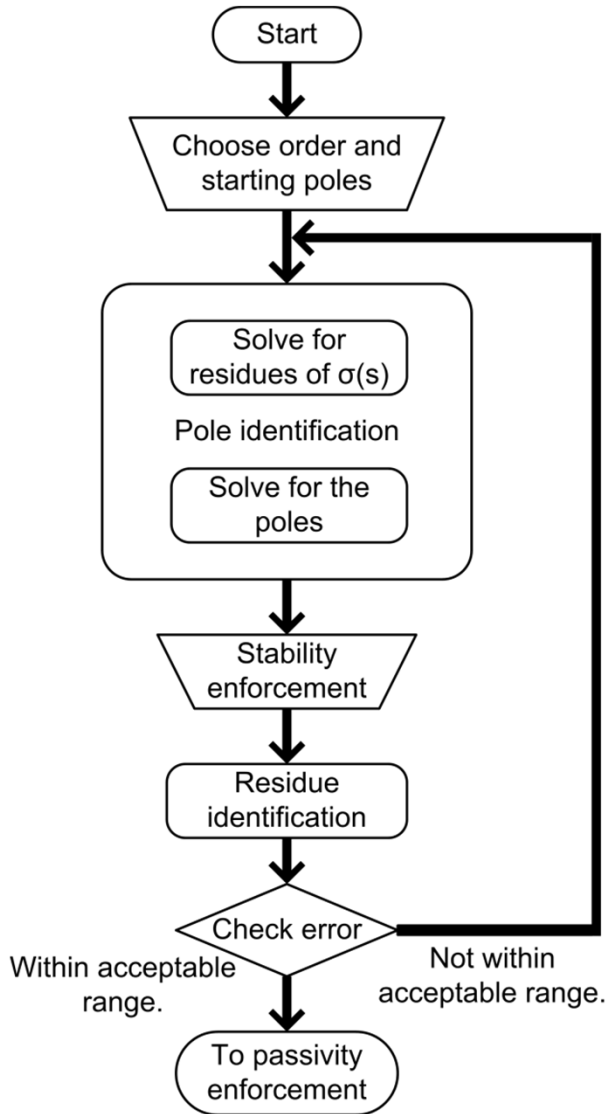


Blackbox Macromodeling



Objective:
Perform time-domain simulation of composite network to determine timing waveforms, noise response or eye diagrams

MOR via Vector Fitting



- Rational function approximation:

$$f(s) \approx \sum_{n=1}^N \frac{c_n}{s - a_n} + d + sh$$

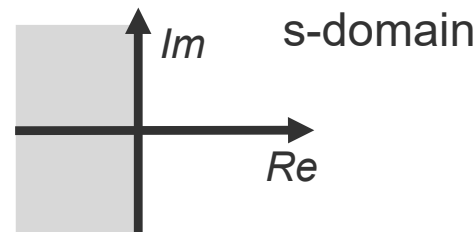
- Introduce an unknown function $\sigma(s)$ that satisfies:

$$\begin{bmatrix} \sigma(s)f(s) \\ \sigma(s) \end{bmatrix} \approx \begin{bmatrix} \sum_{n=1}^N \frac{c_n}{s - \tilde{a}_n} + d + sh \\ \sum_{n=1}^N \frac{\tilde{c}_n}{s - \tilde{a}_n} + 1 \end{bmatrix}$$

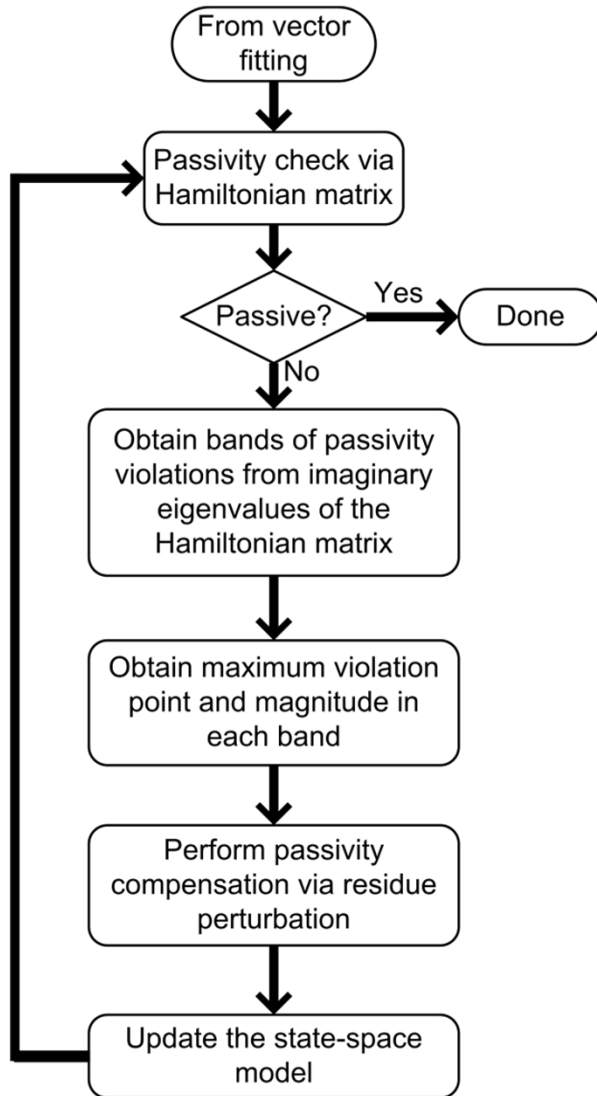
- Poles of $f(s)$ = zeros of $\sigma(s)$:

$$f(s) \approx \frac{\sum_{n=1}^N \frac{c_n}{s - \tilde{a}_n} + d + sh}{\sum_{n=1}^N \frac{\tilde{c}_n}{s - \tilde{a}_n} + 1} = \frac{\prod_{n=1}^{N+1} (s - z_n)}{\prod_{n=1}^N (s - \tilde{z}_n)}$$

- Flip unstable poles into the left half plane.



Passivity Enforcement



- State-space form:

$$\dot{x} = Ax + Bu$$

$$y = Cx + Du$$

- Hamiltonian matrix:

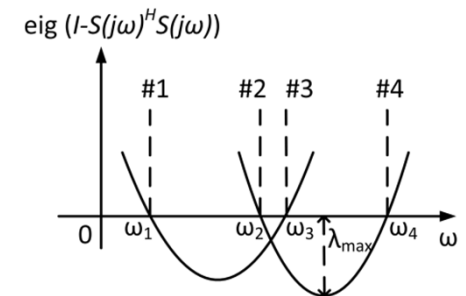
$$M = \begin{bmatrix} A + BKD^T C & BKB^T \\ -C^T LC & -A^T - C^T DKB^T \end{bmatrix}$$

$$K = (I - D^T D)^{-1} \quad L = (I - DD^T)^{-1}$$

- Passive if M has no imaginary eigenvalues.

- Sweep:

$$\text{eig}(I - S(j\omega)^H S(j\omega))$$



- Quadratic programming:

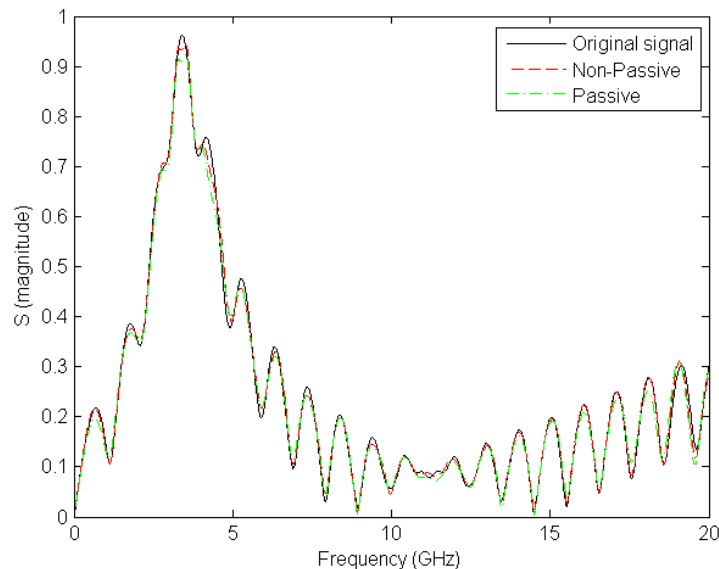
– Minimize (*change in response*) subject to (*passivity compensation*).

$$\min(\text{vec}(\Delta C)^T H \text{vec}(\Delta C)) \quad \text{subject to} \quad \Delta \lambda = G \cdot \text{vec}(\Delta C).$$



Model-Order Reduction

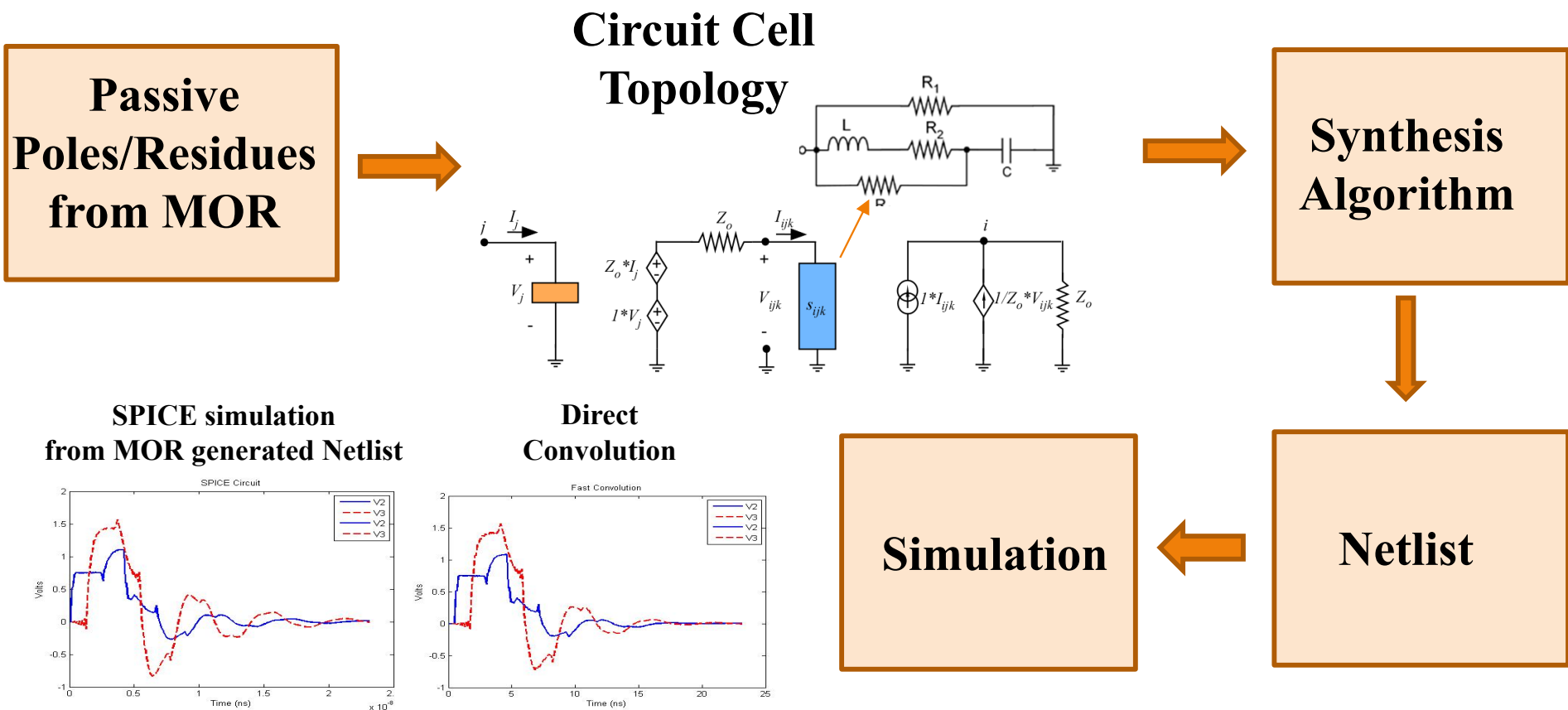
- Start with S parameters from field solver
- Use vector fitting to get poles & residues
- Perform assessment via Hamiltonian
- Enforcement: Residue Perturbation Method
- Simulation: Recursive convolution → **Fast**



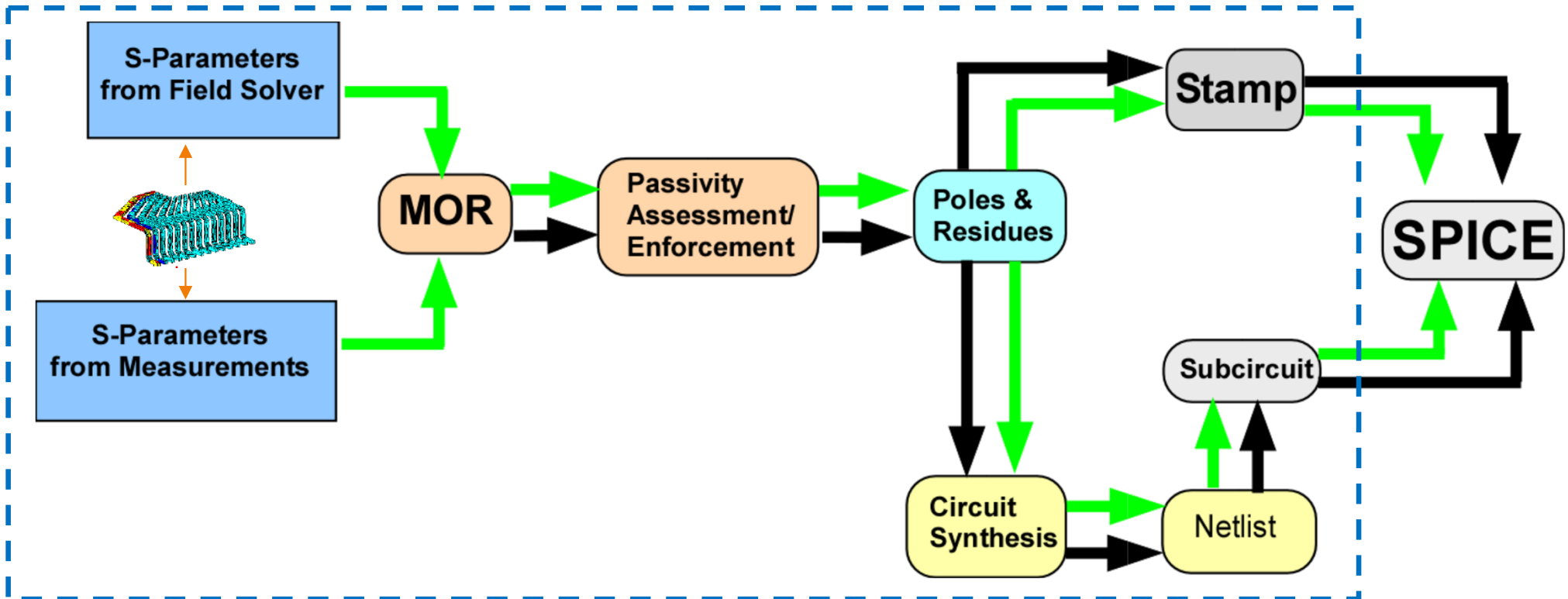
Number of Ports	Order	CPU-Time
4-Port	20	1.7 secs
6-port	32	3.69 secs
10-port	34	8.84 secs
20-port	34	33 secs
40	50	142 secs
80	12	255 secs

SPICE Netlist Synthesis

- Goal is to generate (using pole/residue information) a circuit netlist that will exhibit the same (frequency-dependent) behavior as that of the S-parameters of connector under study



Model-Order Reduction



- **Objective:** Incorporate frequency dependence into time-domain simulator
- **Approaches:** 1) Direct integration of code into SPICE
2) Generation of SPICE-compatible netlist

LIM Support

LIM
Version 0.4
User's Guide

March, 2023
Synclisis, Inc.
Urbana, IL

Copyright 2023 Synclisis, Inc.

- CSIM interface
- Manual Version 0.4
- Product Note
- Application Notes

The image shows the cover of a product note for the Analog/Mixed Signal Simulator. It features the Synclisis logo and a list of features and applications. A diagram of a circuit board is also visible.

synclisis Analog/Mixed Signal Simulator
Product Note

Features

- Rapid transient analyses
- Transistor-level simulations
- Frequency-dependent components
- Full transmission-line analysis
- Large netlists
- Fine step control
- Tunable accuracy and speed
- Chip, package or board

Applications

- Power Delivery Networks
- SI Chip Analysis
- Analog/Mixed Signal Simulation
- Macromodel Analysis
- IC Verification
- High-Speed Link Design

Description

LIM is the first circuit simulator that exhibits linear numerical complexity. This is achieved by using the latency injection method, an algorithm that solves a coupling between current and voltage calculations. Traditional circuit simulators exhibit super-linear numerical complexity. LIM's advantage increases dramatically with the size of the network. In this implementation of LIM, offers both linear and nonlinear elements and devices and will handle frequency-dependent elements via macromodeling. This makes it a universal tool for transient verification at all the levels of integration, chip, package, board and backplane.

CPU TIME COMPARISONS BETWEEN LIM AND THE MODIFIED NODAL ANALYSIS (MNA)

Circuit Size	# nodes	MNA (s)	LIM (s)
20 x 20	1900	0.15	1.03
40 x 40	4720	2.14	0.25
60 x 60	10660	25.73	14.23
80 x 80	19640	140.59	25.71
100 x 100	29800	445.77	40.64
120 x 120	42960	945.00	62.89

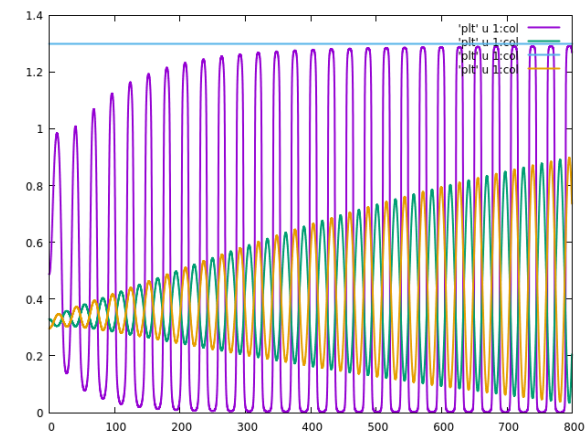
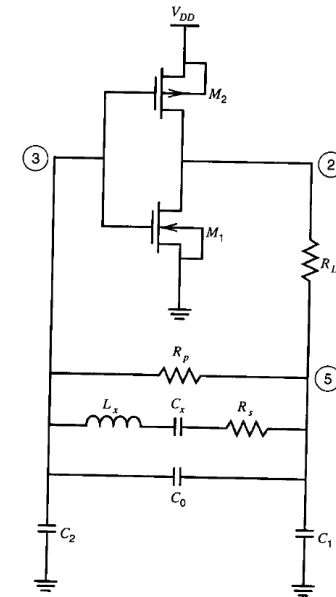
Page 1 of 3 Rev 0.1



LIM Format

➤ SPICE 3 Syntax

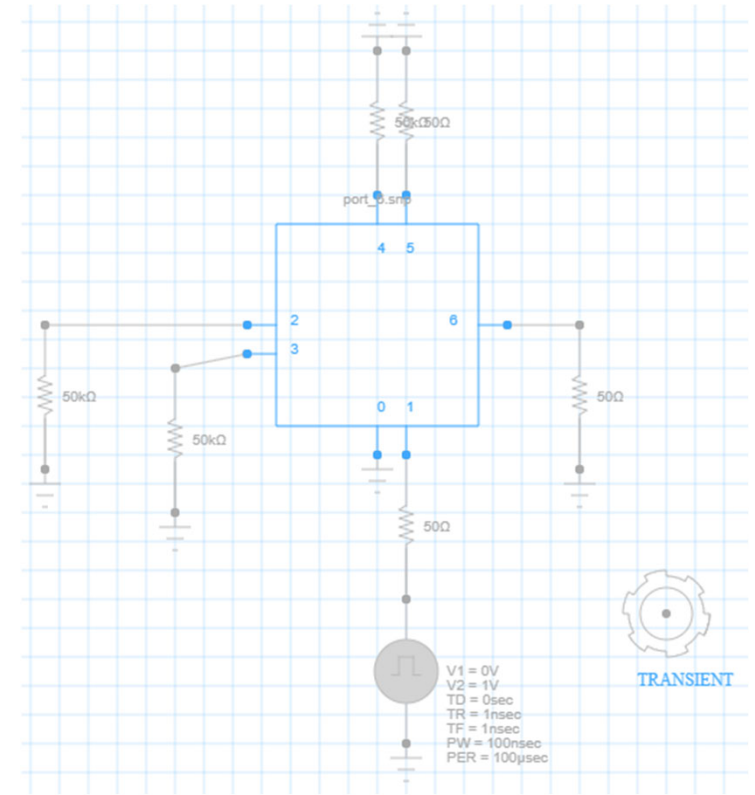
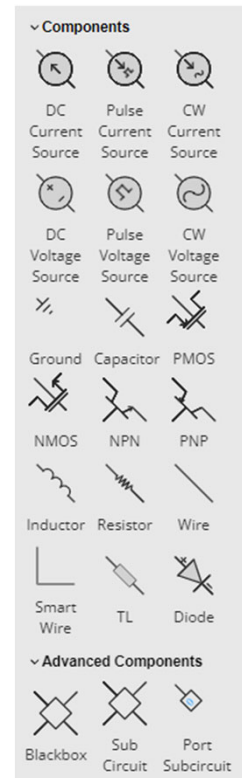
```
*PIERCE XTAL OSCILLATOR WITH CMOS
M1 2 3 0 0 NMOS W=40U L=10U
M2 2 3 1 1 PMOS W=80U L=10U
RL 2 5 10000
C1 5 0 22.0e-12
C2 3 0 22.0e-12
RP 3 5 22.0e+06
LEFF 3 5 0.18e-03
VDD 1 0 5
.MODEL NMOS NMOS LEVEL=1 VTO=1 KP=20U
LAMBDA=0.02
.MODEL PMOS PMOS LEVEL=1 VTO=-1 KP=10U
LAMBDA=0.02
.tran 0.001e-09 6793.0e-09e-08
.LIM C=0.015e-12 L=0.1e-09 G=1.0e-20
.PRINT TRAN V(2) V(3) V(1) V(5)
.PLOT TRAN V(2) V(3) V(1) V(5)
.END
```



CSIM – User Interface

Front-end currently supports general SPICE elements:

- Passive elements: R, L, C
- Independent sources, diodes, transistors
- Sub-circuit (multi-stage: subckts inside subckts)
- Network parameter (S-parameter blackbox)

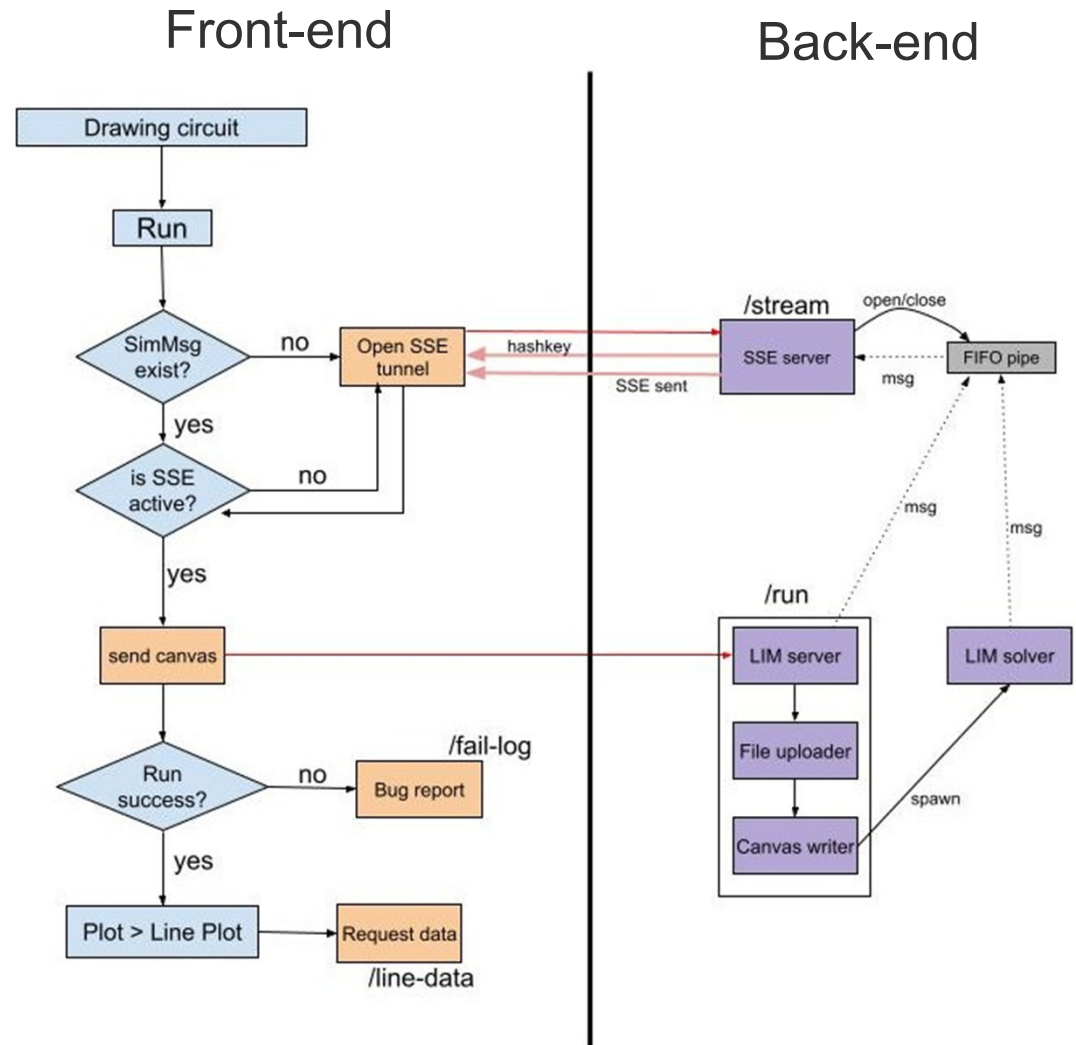


CSIM – User Interface

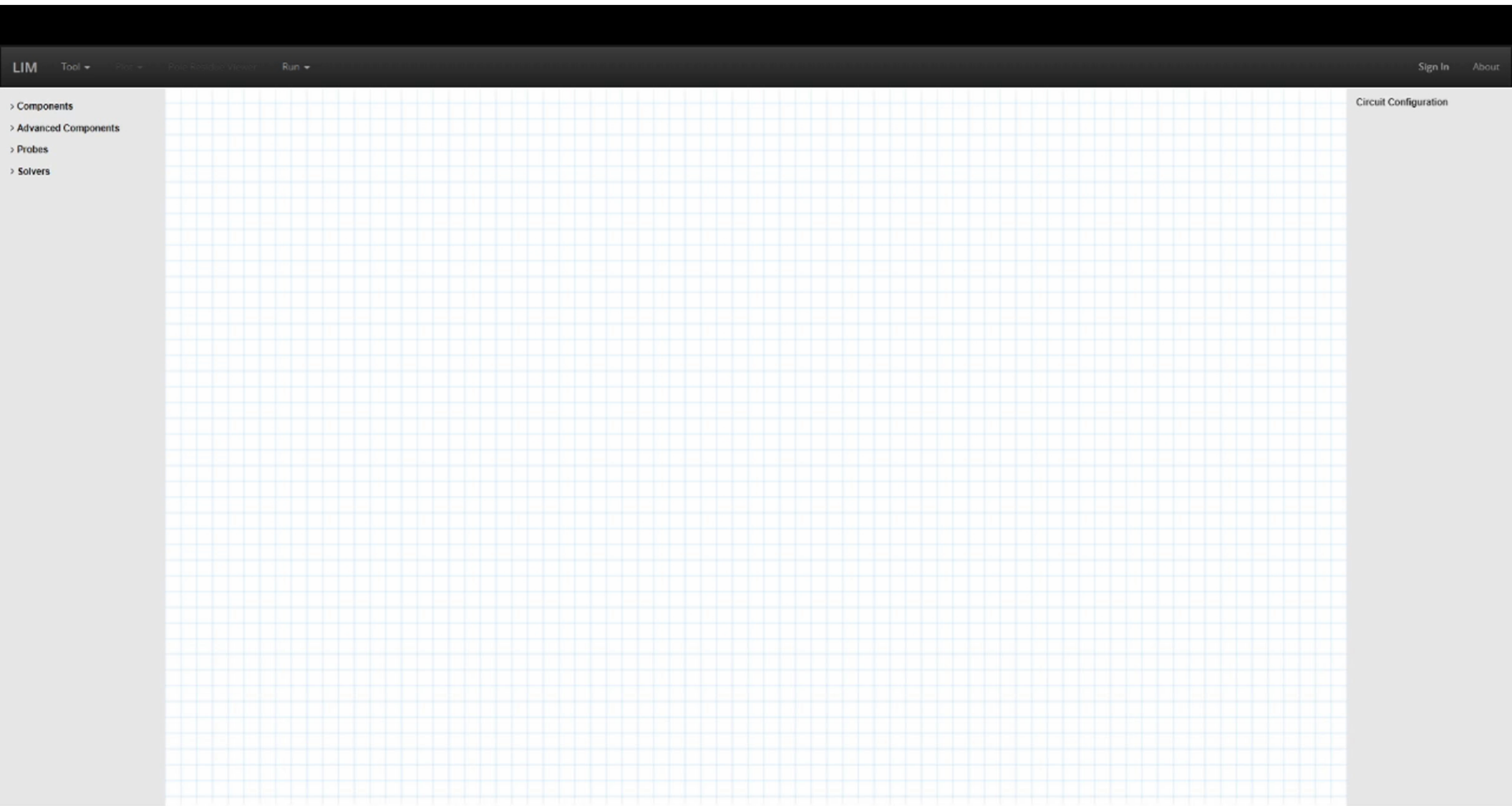
Full-stack overview

Overall flowchart shows on the left:

- Front-end uses React for UI
- Back-end uses NodeJS interfacing LIM engine



LIM/CSIM – Macromodel Example



Pole/Residue Formatting

SDATA_RX5.s4p_poles_and_residues 4-port S-parameter circuit model

185-pole approximation

92 complex pole pairs

0 real poles

===== POLES =====

1 - complex: -1.4132e+09 2.4987e+11

2 - complex: -1.4132e+09 -2.4987e+11

3 - complex: -1.1458e+09 2.4669e+11

4 - complex: -1.1458e+09 -2.4669e+11

:

-----residues for s[1][1]-----

1 - complex: 5.2798e+08 -2.6935e+08

2 - complex: 5.2798e+08 2.6935e+08

3 - complex: 1.2583e+08 1.5229e+08

4 - complex: 1.2583e+08 -1.5229e+08

5 - complex: -1.2293e+08 -9.7733e+07

:



Circuit Formatting

*SDATA/RX5.s4p 4-port S-parameter circuit model
*185 -pole approximation

```
.subckt SUBCIRCUIT 925000 1110000 1295000 1480000  
vsens925001 925000 925001 0.0  
vsens1110001 1110000 1110001 0.0  
vsens1295001 1295000 1295001 0.0  
vsens1480001 1480000 1480001 0.0
```

*subcircuit for s[1][1]

*complex residue-pole pairs for S[1][1] at k= 1 -> 1st pole: -1.4132e+00 2.4987e+02 residue: 5.2798e-01 -2.6935e-01
* -> 2nd pole: -1.4132e+00 -2.4987e+02 residue: 5.2798e-01 2.6935e-01

```
*circuit type = 9  
elc1 1 0 925001 0 1.0  
hc2 2 1 vsens925001 50.0  
rtersc3 2 3 50.0  
vp4 3 4 0.0  
r1cd5 4 0 5.02185e+01  
l1cd5 4 5 -1.86769e-08  
r2cd6 5 6 -2.49907e+03  
c1cd6 6 0 -6.69636e-16  
r3cd6 4 6 1.14941e+04
```

*complex residue-pole pairs for S[1][1] at k= 2 -> 1st pole: -1.1458e+00 2.4669e+02 residue: 1.2583e-01 1.5229e-01
* -> 2nd pole: -1.1458e+00 -2.4669e+02 residue: 1.2583e-01 -1.5229e-01

```
*circuit type = 9  
elc7 7 0 925001 0 1.0  
hc8 8 7 vsens925001 50.0  
rtersc9 8 9 50.0  
vp10 9 10 0.0  
;
```



Conclusions

- LIM can be used to simulate IBIS-based circuits with optimum accuracy.
- LIM can handle macromodels with Vector fitting and produces a circuit netlist.
- CSIM is the LIM interface
- LIM and CSIM are under Development
- LIM is available for beta testing

